

Improving O₂ Production of WO₃ Photoanodes with IrO₂ in Acidic Aqueous Electrolyte

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Supporting Information

Electrode Illumination Schematic.

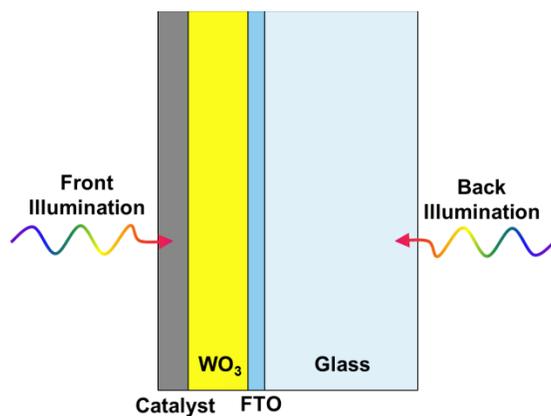


Figure S1. Schematic for OER catalyst/WO₃/FTO/glass photoanodes. Under front illumination conditions, the light was passed through the catalyst layer before getting to the photoactive WO₃. Under back illumination conditions, the light passed through the highly transparent glass substrate and FTO back contact before absorption in the WO₃ layer, without first passing through the catalyst.

IrO₂ on WO₃ Contact.

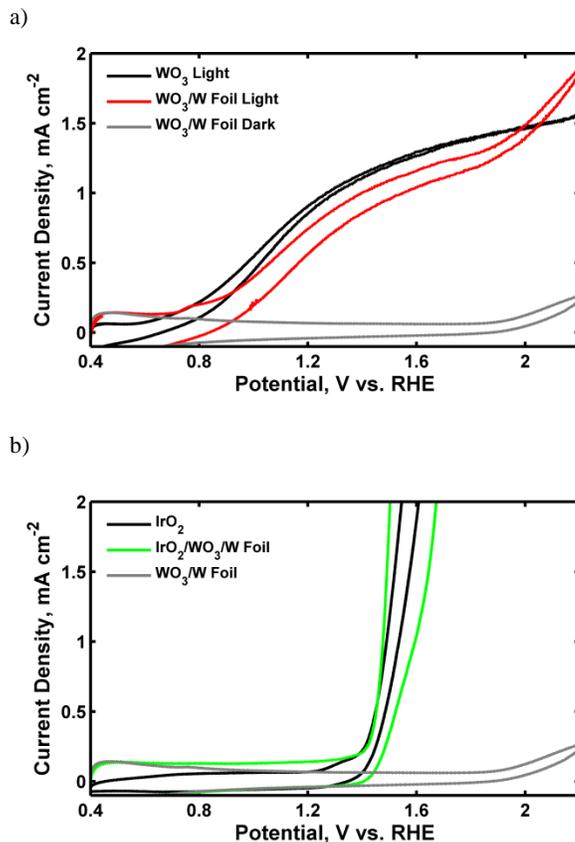


Figure S2. *J-E* behavior for WO₃ on W foil. Photoelectrochemical current-density (J) vs. potential (E) behavior in 1 M H₂SO₄ for (a) front-illuminated (black line) WO₃ on FTO, (red line) front-illuminated WO₃ on W foil, and (gray line) WO₃ on W foil in the dark. (b) Dark *J-E* behavior for (black line) sputtered IrO₂ on FTO, (green line) sputtered IrO₂ on WO₃/W foil, and (gray line) WO₃/W foil.

To ensure that the electrocatalytic current observed on WO₃ photodiodes in reverse bias at > 1.4 V vs. RHE was not due to a shunt caused by IrO₂ deposited directly in contact with the FTO substrate, WO₃ on W foil electrodes were fabricated. By annealing these electrodes in air at 400 °C for 2 hr, all exposed substrate at the bottom of the nanopores and cracks in the bulk WO₃ was oxidized to WO₃ as well. This was demonstrated by the lack of shunting in an electrolyte with a fast, one-electron redox couple (Fig. 1). During sputtering of IrO₂, a mask was used to deposit the catalyst only on the WO₃ film to avoid any contact with the W foil or any edge effects. Nevertheless, as demonstrated in Figure S2b, sputtered IrO₂/WO₃/W foil electrodes displayed electrocatalytic current similar to IrO₂ by itself. The shunt therefore was interpreted to occur through the WO₃ layer.

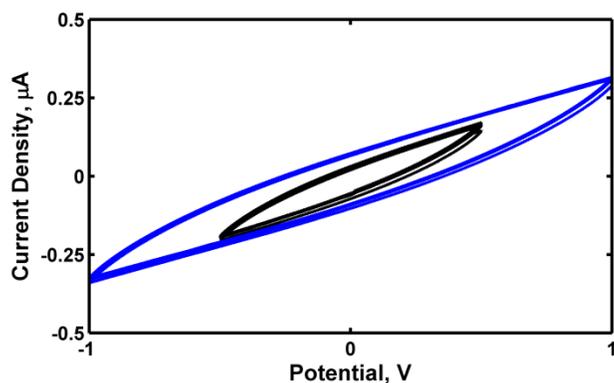


Figure S3. Solid-state cyclic voltammogram for IrO₂ contacts on WO₃. Current vs. voltage (*I*-*V*) behavior for two-electrode CV sweeps at 100 mV s⁻¹ using sputtered IrO₂ contact pads 1 mm apart on WO₃ on glass (without FTO), scanning from (black lines) -0.5 to 0.5 V and from (blue lines) -1.0 to 1.0 V.

To verify the finding of ohmic behavior between the IrO₂ catalyst and WO₃ semiconductor, an attempt was made to directly investigate the nature of the contact with a solid-state measurement. WO₃ was deposited on a cleaned glass slide without an underlying transparent conductive layer, then two IrO₂ contact pads were deposited on the WO₃ by sputtering for 30 min using a mask to define square spots spaced 1 mm apart. A coiled Cu wire was attached to each IrO₂ spot with Ag paint, and these wires were used in two-electrode cyclic voltammograms at various scan rates and potentials. As shown in Figure S3, the resulting currents were low (in the µA range) due to the high resistance of the WO₃ layer. Hysteresis in the data was ascribed to capacitance in the WO₃ layer. Still, the overall trend across a 2 V range was quite linear, an indication of ohmic behavior.

Co₃O₄ and RuO₂ Catalyst Layers.

In addition to IrO₂, the OECs Co₃O₄ and RuO₂ were tested as drop-casted, sintered films and as sputtered films. Due to their instability in the 1 M H₂SO₄ electrolyte used in this work, they were not explored further.

For the drop-cast, sintered catalyst electrodes, three different oxygen-evolving metal oxide catalysts (IrO₂, RuO₂, or Co₃O₄) were separately deposited onto thin WO₃ films by drop-casting solutions of metal salts and then sintering to achieve the oxide form. A micropipette was used to drop-cast 20 μL of a 20 mM solution of the corresponding metal salt (IrCl₃·3H₂O from Fisher Scientific, RuCl₃·xH₂O from Alfa Aesar, or Co(NO₃)₂·6H₂O from Alfa Aesar) in isopropanol on a ~1 cm² area of the WO₃. These films were allowed to dry at room temperature for ~1 hr then sintered at 400 °C in air for 1 hr. Analogous electrodes of the OEC directly on FTO glass were produced by the same method.

For the sputtered catalyst electrodes, OEC films of IrO₂, RuO₂, or Co₃O₄ were sputtered from metal targets of Ir, Ru, or Co (all ≥ 99.9% from AJA International), respectively. In each case, the catalyst layer was sputtered onto the WO₃ film from an RF source at 200 W at 300 °C under a constant flow of 3.0/3.0 sccm Ar/O₂ for IrO₂ and 4.5/0.5 sccm Ar/O₂ for RuO₂ and Co₃O₄ while maintaining an overall pressure of 6 mtorr. Two different thicknesses of each catalyst were produced by sputtering for either 0.5 min (< 10 nm) or 30 min (> 100 nm). Analogous electrodes of the OEC directly on FTO glass were produced by the same method.

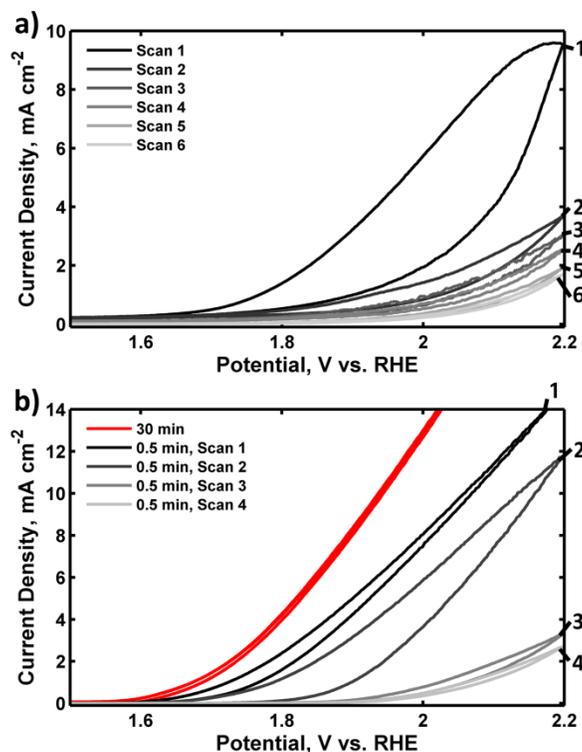


Figure S4. Instability of Co₃O₄ during cyclic voltammetry. *J-E* behavior in 1 M H₂SO₄ of (a) sintered Co₃O₄ on WO₃ over 6 scans, and (b) sputtered Co₃O₄ on FTO/glass over 4 scans. Thin, 0.5 min sputtered Co₃O₄ decayed rapidly over 4 scans (black to gray lines). Although thick, 30 min sputtered Co₃O₄ (red line) appeared stable over 4 scans, the current decayed away after extended use (> 1 hr) in 1 M H₂SO₄.

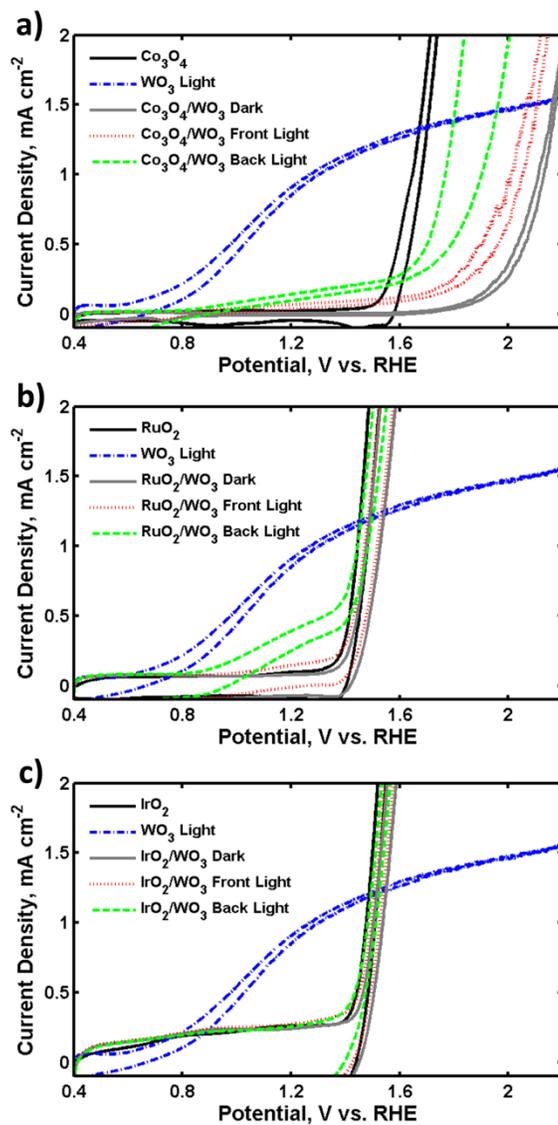


Figure S5. *J-E* behavior for drop-cast, sintered OER catalysts on WO₃. Photoelectrochemical current-density (*J*) vs. potential (*E*) behavior in 1 M H₂SO₄ for (a) Co₃O₄, (b) RuO₂, and (c) IrO₂ sintered from drop-cast metal salt solutions on WO₃ thin films and annealed in air at 400 °C for 1 hr. Performance is shown for (green lines) back illumination, (red lines) front illumination, and (gray lines) in the dark, with (blue lines) bare WO₃ under illumination and (black lines) the catalyst by itself in the dark for reference.

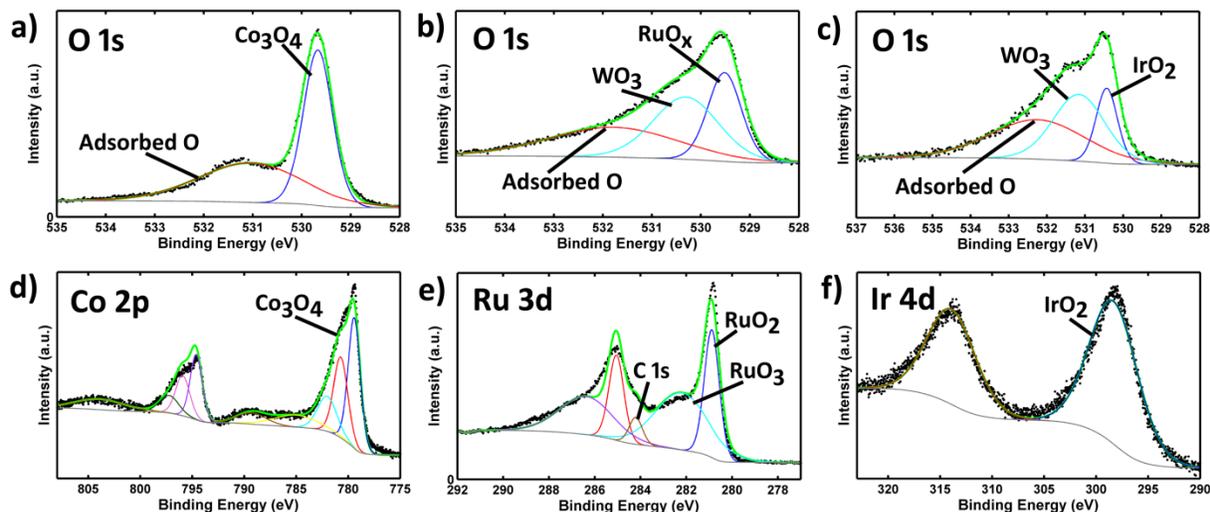


Figure S6. XPS of sputtered OER catalyst films on WO_3 photoanodes. High resolution scans for sputtered (a,d) Co_3O_4 , (b,e) RuO_2 , and (c,f) IrO_2 on WO_3 thin films. The (a-c) O 1s, (d) Co 2p, (e) Ru 3d, and (f) Ir 4d regions are shown. The RuO_2 and IrO_2 films were sputtered for 0.5 min, but the Co_3O_4 film was sputtered for 30 min to obtain a better Co 2p signal for clearer peak fitting.

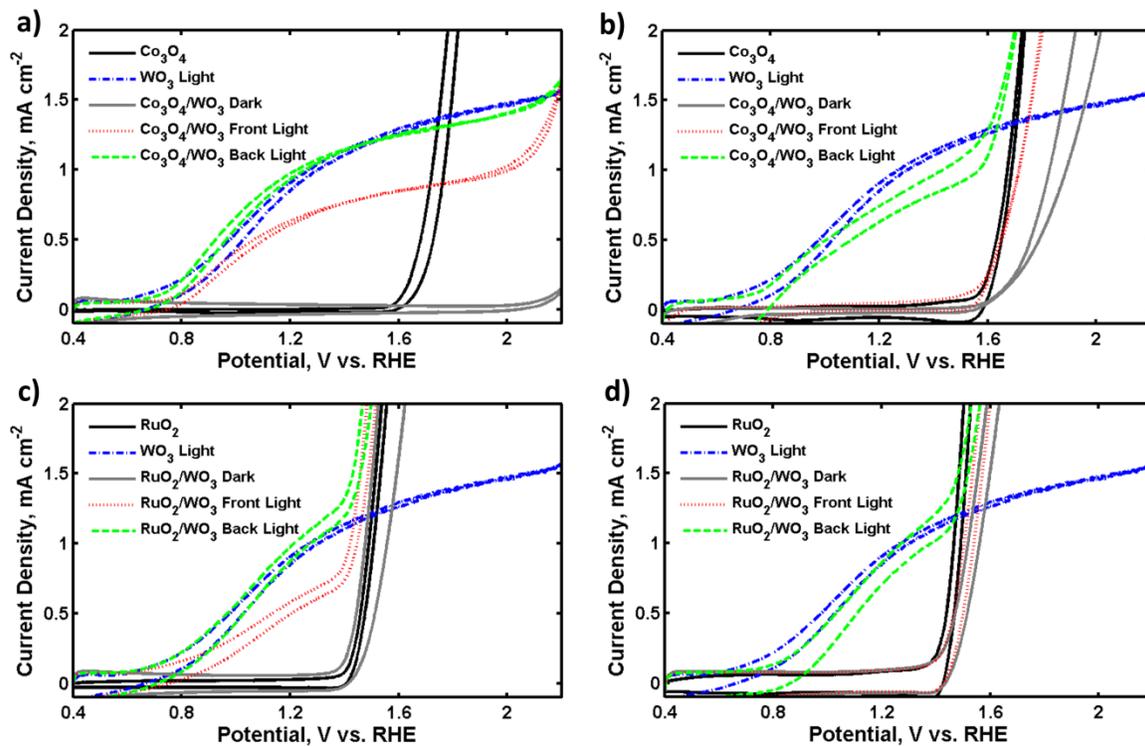


Figure S7. J - E behavior for sputtered OER catalyst on WO_3 . Photoelectrochemical current-density (J) vs. potential (E) behavior in 1 M H_2SO_4 for (a,c) 0.5 min sputtered and (b,d) 30 min sputtered films of (a,b) Co_3O_4 , and (c,d) RuO_2 on WO_3 . Performance is shown for (green lines) back illumination, (red lines) front illumination, and (gray lines) in the dark, with (blue lines) bare WO_3 under illumination and (black lines) the catalyst by itself in the dark for reference.

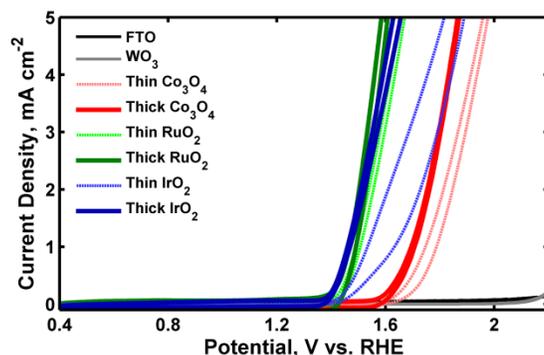


Figure S8. Dark J - E behavior for sputtered OER catalysts. Dark electrochemical current-density (J) vs. potential (E) behavior in 1 M H_2SO_4 for (black) FTO, (gray) WO_3 , (light red, dashed) thin sputtered Co_3O_4 , (dark red) thick sputtered Co_3O_4 , (light green, dashed) thin sputtered RuO_2 , (dark green) thick sputtered RuO_2 , (light blue, dashed) thin sputtered IrO_2 , and (dark blue) thick sputtered IrO_2 .

Optical Transmittance for Sintered and Sputtered IrO_2 Layers.

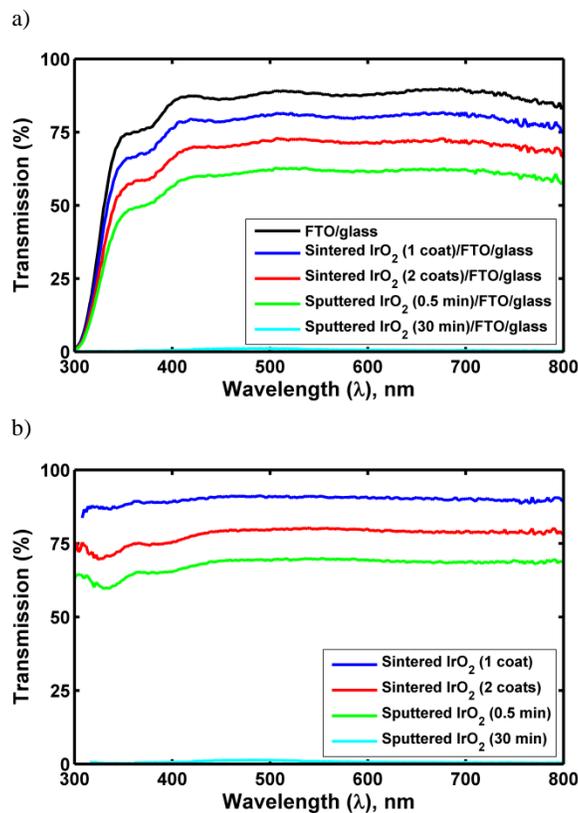


Figure S9. Optical transmission of IrO_2 catalyst layers. The percent of light transmitted vs. wavelength for sintered and sputtered IrO_2 layers on (a) FTO/glass substrates and (b) baseline-corrected for FTO/glass substrates to determine transmission only through the IrO_2 layer.

Annealing Sputtered IrO₂/WO₃ Photoanodes.

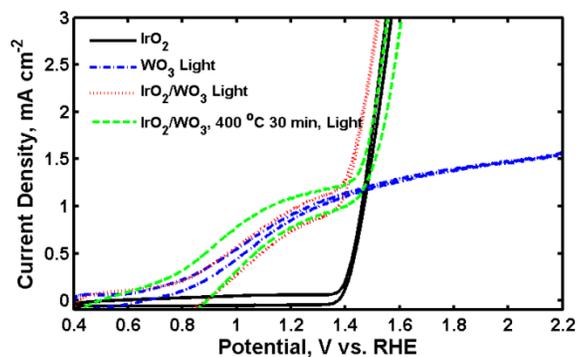


Figure S10. *J-E* behavior for annealed, sputtered IrO₂ on WO₃. Photoelectrochemical current-density (*J*) vs. potential (*E*) behavior in 1 M H₂SO₄. Performance is shown for 30 min sputtered IrO₂/WO₃ (red lines) as-deposited and (green lines) annealed under back illumination, with (blue lines) bare WO₃ under illumination and (black lines) the catalyst by itself in the dark for reference. Annealed samples were heated in air at 400 °C for 30 min.

IrO₂ Catalyst Layer Morphology.

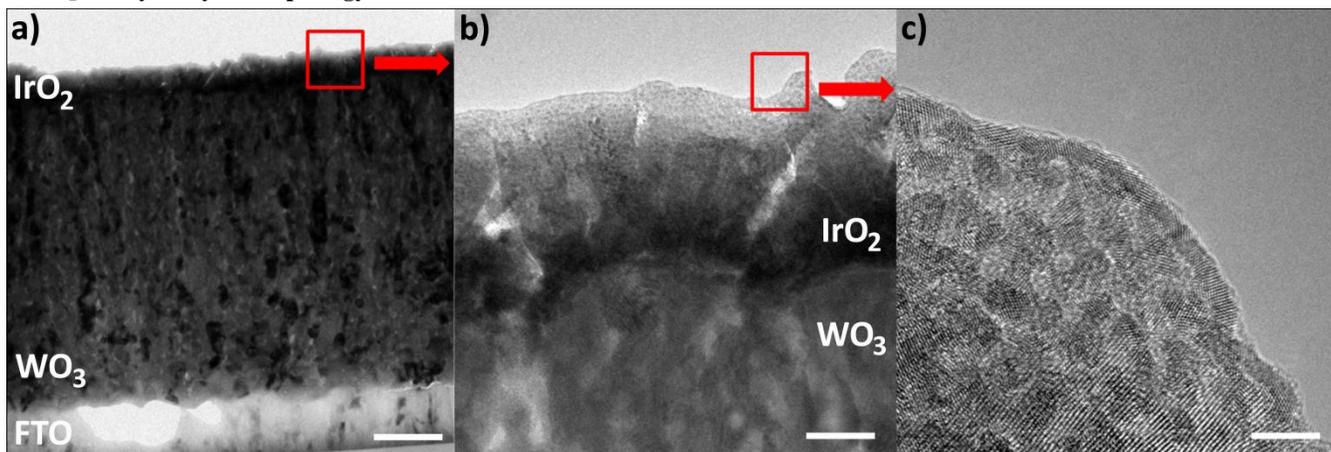


Figure S11. Morphology of sputtered IrO₂ layer. Cross-sectional TEM images for 30 min sputtered IrO₂ on WO₃ with a scale bar of (a) 200 nm, (b) 30 nm, and (c) 5 nm.

O₂ Production Measurements.

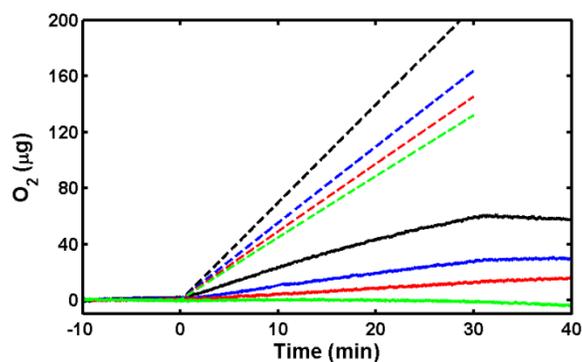


Figure S12. O₂ production of a bare WO₃ photoanode. The amount of O₂ produced by a bare, sputtered WO₃ film in 1 M H₂SO₄ under illumination while biased at a given potential, as determined by (dashed lines) the total charge passed (assuming 100% faradaic conversion to O₂) and by (solid lines) an optical O₂ sensor. The WO₃ photoanode was biased at potentials of (green lines) 1.4 V, (red lines) 1.5 V, (blue lines) 1.6 V, and (black lines) 2.0 V vs. RHE.

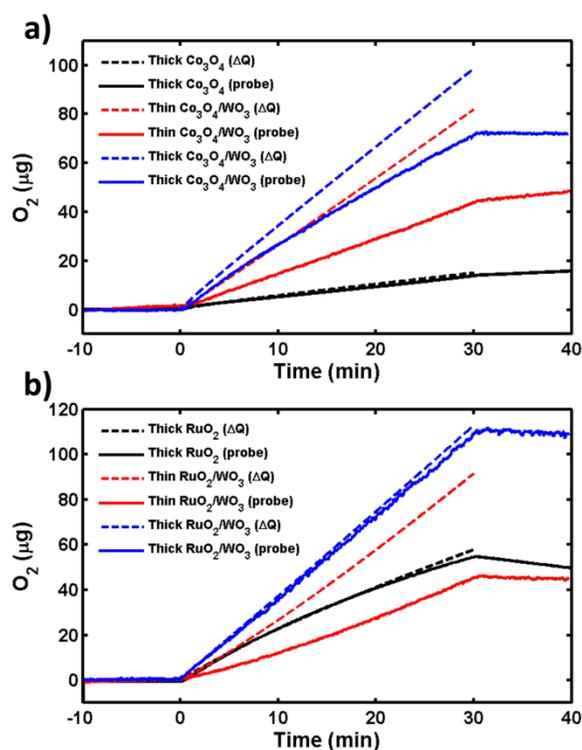


Figure S13. O₂ production of sputtered OER catalysts on WO₃. The amount of O₂ produced at 1.2 V vs. RHE under back illumination in 1 M H₂SO₄ for a WO₃ photoanode with a sputtered catalyst film of (a) Co₃O₄, and (b) RuO₂. The quantity of O₂ was determined by (dashed lines) the total charge passed (assuming 100% faradaic conversion to O₂) and by (solid lines) an optical O₂ sensor. For catalyst thicknesses, (red lines) a thin film was sputtered for 0.5 min, and (blue lines) a thick film was sputtered for 30 min. To demonstrate the high faradaic efficiency achievable with each catalyst, (black lines) bare catalyst films were measured in the dark at 1.5 V vs. RHE (RuO₂) or 1.7 V vs. RHE (Co₃O₄).

Electrode Stability.

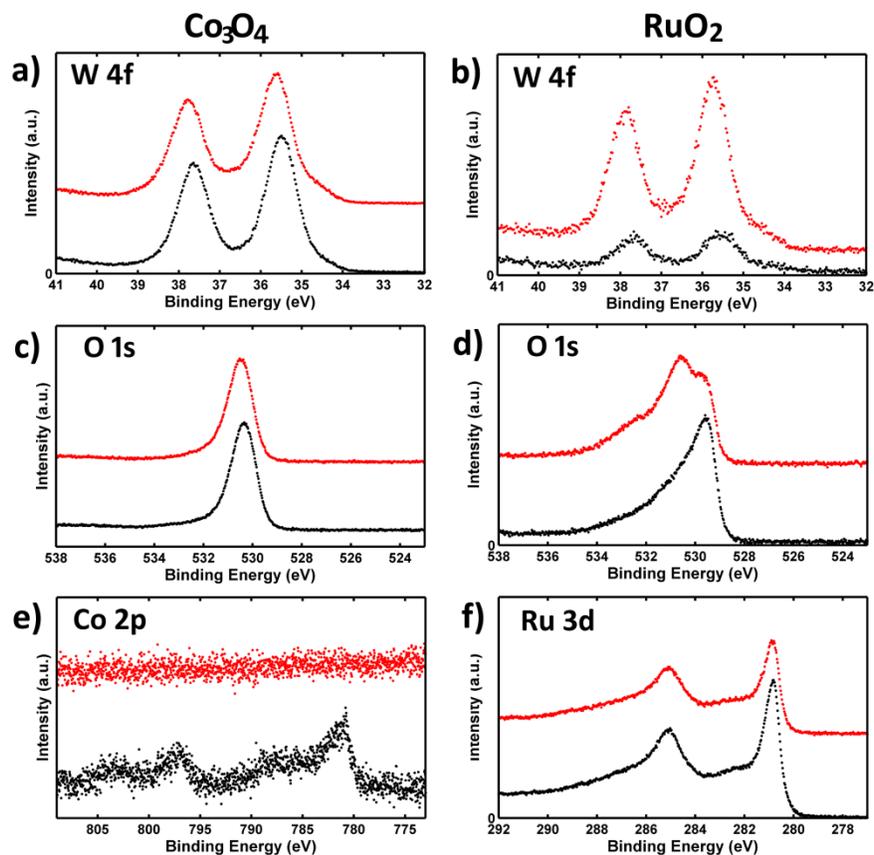


Figure S14. XPS of sputtered OER catalysts on WO_3 . High resolution XPS spectra for WO_3 films covered with (a, c, e) Co_3O_4 , and (b, d, f) RuO_2 , each sputtered for 0.5 min. The regions shown are (a,b) W 4f, (c,d) O 1s, (e) Co 2p, and (f) Ru 3d. The films were analyzed (black lines) as-deposited, and (red lines) after a J - E behavior measurement under illumination in 1 M H_2SO_4 .

Figure S14 shows the XPS spectra for thin, 0.5 min sputtered OEC/ WO_3 electrodes in which the catalyst layer was thin enough to allow sampling of the underlying WO_3 . As expected from the decay in current observed during J - E measurements (Fig. S4), the Co_3O_4 Co 2p signal is completely gone after measurement in 1 M H_2SO_4 (Fig. S14e). Although the catalytic current with RuO_2 was much steadier, the XPS results reveal that this OEC was not long-term stable in strong acid either. After measuring the J - E behavior, the W 4f peaks of the RuO_2/WO_3 sample became more intense (Fig. S14b) and the O 1s peak changed such that the WO_3 component became more prominent relative to the RuO_x component (Fig. S14d and Fig. S6b), indicating the gradual dissolution of the RuO_2 layer.

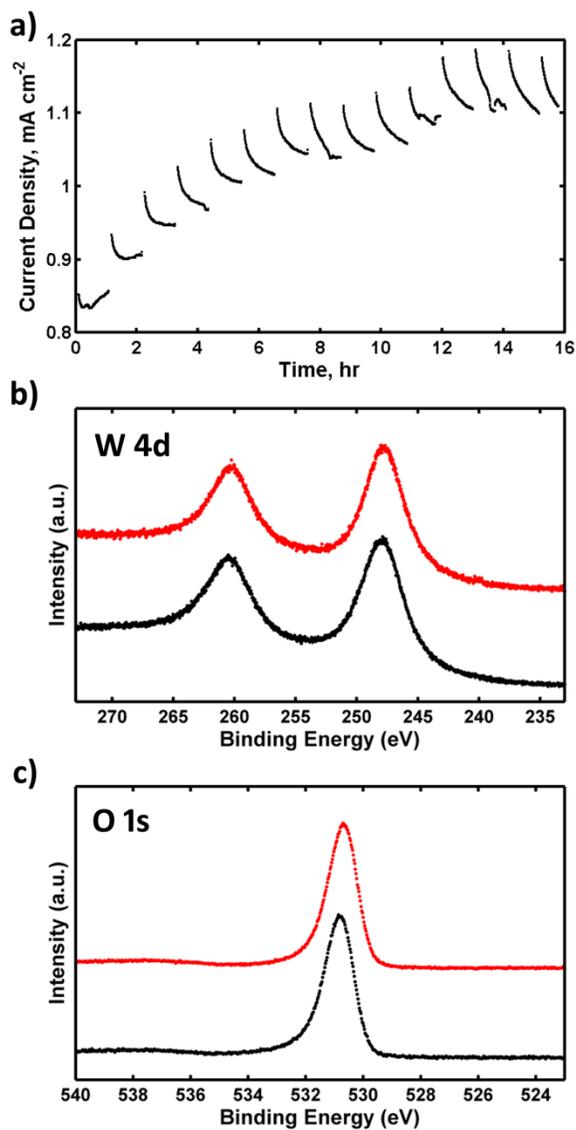


Figure S15. Stability of WO₃ photoanodes. (a) Current density vs. time measurement for bare WO₃ in 1 M H₂SO₄ under 1 sun AM1.5 illumination at 1.2 V vs. RHE with cyclic voltammetric (CV) measurements (30 mV s⁻¹ scan from 0.4 to 2.0 V vs. RHE and back, 2 scans) made every hour. The discontinuities in the curve are due to the CV measurements. (b, c) XPS data for sputtered WO₃ films (black lines) as-deposited and (red lines) after 12 hr at 1.2 V vs. RHE in 1 M H₂SO₄ under 1 sun AM1.5 illumination showing high resolution scans of (b) the W 4d region and (c) the O 1s region.

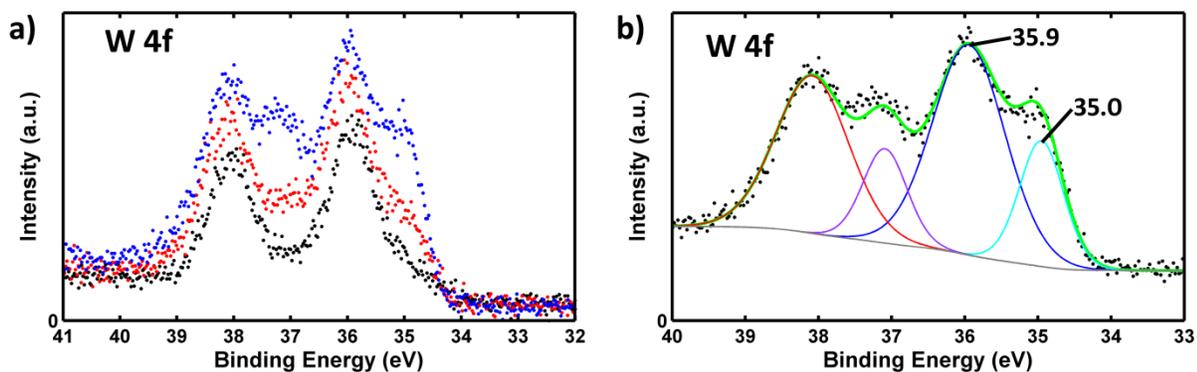


Figure S16. Stability of sputtered IrO_2 on WO_3 . XPS spectra of the W 4f region of thin, 0.5 min sputtered IrO_2 on WO_3 , showing (a) the sequential change from (black lines) as-deposited to (red lines) after a $J-E$ behavior measurement under illumination in 1 M H_2SO_4 , to (blue lines) after 12 hr at 1.2 V vs. RHE under illumination in 1 M H_2SO_4 . Also shown are (b) the fitted peaks for the sample after 12 hr at 1.2 V vs. RHE under illumination in 1 M H_2SO_4 .

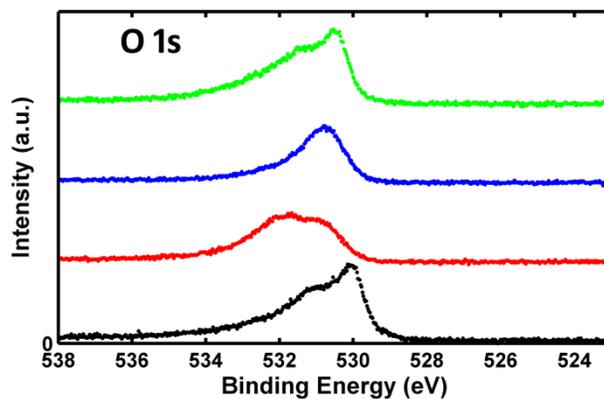


Figure S17. XPS comparison of different IrO_2 deposition methods. XPS spectra of the O 1s region of WO_3 with IrO_2 deposited on it by (black line) drop-casting an IrCl_3 solution and then sintering at 400 °C for 1 hr, (red line) electrodeposition, (blue line) electrodeposition followed by a 400 °C anneal for 1 hr, and (green line) sputtering for 0.5 min.

Electrodeposited IrO₂ on WO₃ Photoanodes.

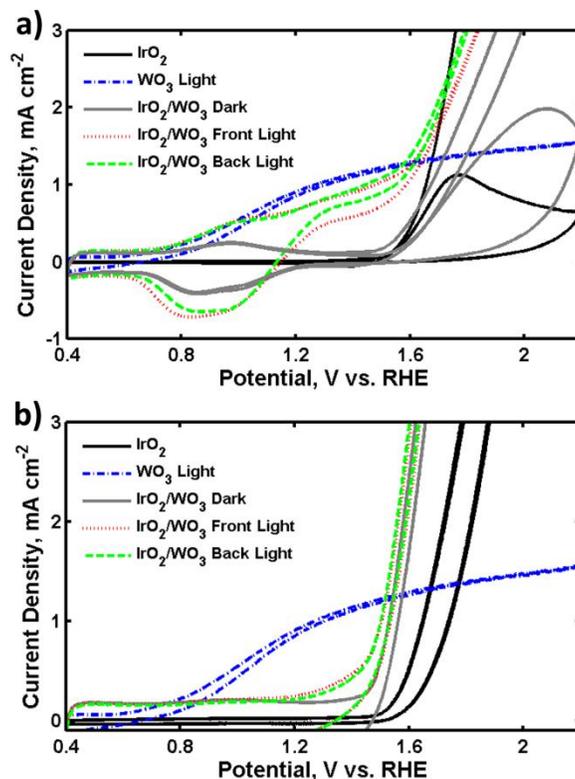


Figure S18. *J-E* behavior for electrodeposited IrO₂ on WO₃ by the method of Zhao et al.¹ Photoelectrochemical current-density (*J*) vs. potential (*E*) behavior in 1 M H₂SO₄ for electrodeposited IrO₂ on WO₃ (a) as-deposited and (b) after a 400 °C anneal for 1 hr. Performance is shown for (green lines) back illumination, (red lines) front illumination, and (gray lines) in the dark, with (blue lines) bare WO₃ under illumination and (black lines) the catalyst by itself on FTO in the dark for reference. Multiple successive scans of IrO₂/WO₃ in the dark and IrO₂ on FTO are included to demonstrate unstable current in (a) and stable current in (b).

For this IrO₂ electrodeposition procedure, colloidal IrO_x in a pH 1 mixture was prepared as published.¹ The solution was stored in a refrigerator at 4 °C. IrO_x films were deposited on FTO/glass and on WO₃ by maintaining the potential at 1.4 V vs. Ag/AgCl until 2.5 C of charge had been passed. In each case, the exposed area of the working electrode for deposition was 1 cm². During deposition, the solution was stirred vigorously and kept in an ice bath.

Drop-cast, Particulate IrO₂ on WO₃ Photoanodes. Another method tested for IrO₂ catalyst attachment was the drop-casting of IrO₂ powders directly on the WO₃ surface. IrO₂ powder (99%, Alfa Aesar) was mixed to a 30% w/w IrO₂ suspension in isopropanol and then sonicated for > 3 hr before drop-casting 20 μL of the suspension onto a 1 cm² WO₃ electrode area using a micropipette and drying in ambient for ~ 1 hr. Eight sequential coatings of IrO₂ particles were applied. Some particulate IrO₂/WO₃ electrodes were also annealed at 500 °C for 2 hr in air. Analogous electrodes of IrO₂ particles directly on FTO glass were produced by the same method.

Before any annealing step, particulate IrO₂/WO₃ photoanodes performed comparably to bare WO₃ under back illumination, but with the photocurrent was reduced by 68% due to catalyst light absorption under front illumination (Table 1). However, these samples displayed no O₂ production and had issues with catalyst loss due to poor adhesion. After annealing to sinter the catalyst particles to the WO₃ surface, most IrO₂ particles remained attached during testing. A reduction in photocurrent was observed after the high temperature anneal, but the faradaic oxygen production efficiency increased from 0 to 43% (Table 1). Considering the relatively low O₂ yield compared to the percentage of photocurrent lost under front illumination, this catalyst attachment method was not pursued further. However, a more sophisticated technique to pattern IrO₂ particles at set dimensions to optimize catalytic activity relative to optical absorption may still hold promise for future studies.

1. Y. X. Zhao, E. A. Hernandez-Pagan, N. M. Vargas-Barbosa, J. L. Dysart and T. E. Mallouk, *J. Phys. Chem. Lett.*, 2011, **2**, 402-406.